

Form 1449 (Modified)

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Information Disclosure  
Statement By Applicant

(Use Several Sheets If Necessary)

Attorney Docket No.

U.S.

LAM2P468

10/816,431

Applicant:

Anderson II, et al.

Filing Date:

Group:

March 31, 2004

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## U.S. Patent Documents

Examiner Initial	No.	Patent No.	Date	Patentee	Class	Sub-class
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	F/	5,800,248	09/1998	Pant et al.	451	041
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	H/	5,888,126	03/1999	Hirose et al.	451	287
	I/	5,931,719	08/1999	Nagahara et al.	451	041
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	M/	6,126,527	10/2000	Kao et al.	451	307
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	O/	6,135,859	10/2000	Tietz	451	041
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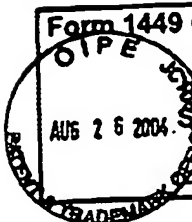
## Foreign Patent or Published Foreign Patent Application

Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
DVW	Q/	EP0920956	06/1999	EPO	/	/	x	
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## Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
	W	
	X	
	Y	
	Z	
Examiner Dung van Nguyen		Date Considered 12-3-2004

Examiner: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<b>Form 1449 (Modified)</b> 	<b>Information Disclosure Statement By Applicant</b>		<b>Atty Docket No:</b>	<b>U.S.</b>
			LAM2P468	10/816,431
			<b>Applicants:</b>	
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		March 31, 2004	3723	

(Use Several Sheets If Necessary)

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*	M2/	6,234,878	05/2001	Moore	451	041

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Examiner Initial	No.	Document No.	Publication Date	Country or Patent Office	Class	Sub-class	Translation	
							Yes	No
dvw	N/	JP 410 144709 A	—	JPO	—	—		X
	O							
	P							
	Q							

### Other Documents

Examiner Initial	No.	Author, Title, Date, Place (e.g. Journal) of Publication
	R	
	S	
Examiner <i>Dring von Nguyen</i>		Date Considered 12-3-2004

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